

Search Notes				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/666,431	TANASE ET AL.	
				Examiner	Art Unit	
				Naoko Slack	3635	

SEARCHED			
Class	Subclass	Date	Examiner
52	783.11	5/5/2006	NS
52	783.17	5/5/2006	NS
52	783.18	5/5/2006	NS
52	783.19	5/5/2006	NS
52	793.1	5/5/2006	NS
52	481.1	5/5/2006	NS
52	309.8	5/5/2006	NS
52	309.9	5/5/2006	NS
52	794.1	5/5/2006	NS
52	783.1	5/29/07	BF
	783.11		
	790.1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PALM: inventors related cases (see printouts)	5/5/2006	NS
UPDATE Search. F/B relevant art	10/5/06	TK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner